



Element Materials Technology

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RF EXPOSURE PART 0 TEST REPORT

Applicant Name:

Apple, Inc.
One Apple Park Way
Cupertino, CA 95014

Date of Testing:

06/12/2026 – 07/14/2026

Test Report Issue Date:

08/14/2026

Test Site/Location:

Element, Morgan Hill, CA, USA

Document Serial No.:

1C2604100027-22.BCG

FCC ID:

BCG-A3579

APPLICANT:

APPLE, INC.

Report Type:

Part 0 SAR Characterization

DUT Type:

Watch

Model(s):

A3579, A3580

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Test results reported herein relate only to the item(s) tested.

RJ Ortanez
Executive Vice President



FCC ID: BCG-A3579	DUT Type: Watch	RF EXPOSURE PART 0 TEST REPORT	Approved by: Technical Manager
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1 DEVICE UNDER TEST

1.1 Device Overview

This device uses MediaTek's time-averaged SAR (TAS) feature to control and manage transmitting power in real time and to ensure the time-averaged RF exposure is in compliance with the FCC requirement at all times for WWAN operations. Additionally, this device supports WLAN/BT/802.15.4 ab-NB/UWB, NFC technologies, but the output power of these modems is not controlled by the Smart Transmit algorithm.

Band & Mode	Operating Modes	Tx Frequency
LTE Band 71	Voice/Data	665.5 - 695.5 MHz
LTE Band 12	Voice/Data	699.7 - 715.3 MHz
LTE Band 17	Voice/Data	706.5 - 713.5 MHz
LTE Band 13	Voice/Data	779.5 - 784.5 MHz
LTE Band 14	Voice/Data	790.5 - 795.5 MHz
LTE Band 26 (Cell)	Voice/Data	814.7 - 848.3 MHz
LTE Band 5 (Cell)	Voice/Data	824.7 - 848.3 MHz
LTE Band 66 (AWS)	Voice/Data	1710.7 - 1779.3 MHz
LTE Band 4 (AWS)	Voice/Data	1710.7 - 1754.3 MHz
LTE Band 25 (PCS)	Voice/Data	1850.7 - 1914.3 MHz
LTE Band 2 (PCS)	Voice/Data	1850.7 - 1909.3 MHz
LTE Band 7	Voice/Data	2502.5 - 2567.5 MHz
LTE Band 41	Voice/Data	2498.5 - 2687.5 MHz
LTE Band 53	Voice/Data	2484.2 - 2494.3 MHz
NR Band n71	Voice/Data	665.5 - 695.5 MHz
NR Band n12	Voice/Data	701.5 - 713.5 MHz
NR Band n14	Voice/Data	790.5 - 795.5 MHz
NR Band n26 (Cell)	Voice/Data	816.5 - 846.5 MHz
NR Band n5 (Cell)	Voice/Data	826.5 - 846.5 MHz
NR Band n66 (AWS)	Voice/Data	1712.5 - 1777.5 MHz
NR Band n25 (PCS)	Voice/Data	1852.5 - 1912.5 MHz
NR Band n2 (PCS)	Voice/Data	1852.5 - 1907.5 MHz
NR Band n53	Voice/Data	2488.2 - 2490 MHz
NR Band n7	Voice/Data	2502.5 - 2567.5 MHz
NR Band n41	Voice/Data	2505.0 - 2685.0 MHz
NTN Band 254	Data	1610.2 - 1626 MHz
2.4 GHz WIFI	Voice/Data	2412 - 2472 MHz
5 GHz WIFI	Voice/Data	U-NII-1: 5180 - 5240 MHz U-NII-2A: 5260 - 5320 MHz U-NII-2C: 5500 - 5720 MHz U-NII-3: 5745 - 5825 MHz
2.4 GHz Bluetooth	Data	2402 - 2480 MHz
802.15.4 ab-NB	Data	5728.75 - 5846.25 MHz
NFC	Data	13.56 MHz
UWB	Data	6489.6 - 7987.2 MHz

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1.2 Time-Averaging for SAR

This device is enabled with MediaTek TAS algorithm to control and manage transmitting power in real time and to ensure that the time-averaged RF exposure from WWAN is in compliance with FCC requirements. This Part 0 report shows SAR characterization of WWAN sub-6 radios. Characterization is achieved by determining P_{sub6_limit} for Sub-6 radio that corresponds to the exposure design targets after accounting for all device design related uncertainties, i.e., SAR_design_limit (< FCC SAR limit) for sub-6 radio. The SAR characterization is denoted as SAR Char in this report. Section 1.3 includes a nomenclature of the specific terms used in this report.

The compliance test under the static transmission scenario and simultaneous transmission analysis are reported in Part 1 report. The validation of the time-averaging algorithm and compliance under the dynamic (time- varying) transmission scenario for WWAN technologies are reported in Part 2 report (report SN could be found in Section 1.4 – Bibliography).

1.3 Nomenclature for Part 0 Report

Technology	Term	Description
WWAN	P_{sub6_limit}	Power level that corresponds to the exposure design target (SAR_design_limit) after accounting for all device design related uncertainties
	P_{UE_max}	Maximum tune up output power
	SAR_design_limit	Target SAR level < FCC SAR limit after accounting for all device design related uncertainties
	SAR_Char	Table containing P_{sub6_limit} for all technologies and bands

1.4 Bibliography

Report Type	Report Serial Number
RF Exposure Part 1 Test Report	1C2604100027-23.BCG
RF Exposure Part 2 Test Report	1C2604100027-24.BCG

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2 SAR MEASUREMENTS

2.1 SAR Definition

Specific Absorption Rate is defined as the time derivative (rate) of the incremental energy (dU) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dV) of a given density (ρ). It is also defined as the rate of RF energy absorption per unit mass at a point in an absorbing body (see Equation 2-1).

Equation 2-1
SAR Mathematical Equation

$$SAR = \frac{d}{dt} \left(\frac{dU}{dm} \right) = \frac{d}{dt} \left(\frac{dU}{\rho dv} \right)$$

SAR is expressed in units of Watts per Kilogram (W/kg).

$$SAR = \frac{\sigma \cdot E^2}{\rho}$$

where:

σ	=	conductivity of the tissue-simulating material (S/m)
ρ	=	mass density of the tissue-simulating material (kg/m ³)
E	=	Total RMS electric field strength (V/m)

NOTE: The primary factors that control rate of energy absorption were found to be the wavelength of the incident field in relation to the dimensions and geometry of the irradiated organism, the orientation of the organism in relation to the polarity of field vectors, the presence of reflecting surfaces, and whether conductive contact is made by the organism with a ground plane.[6]

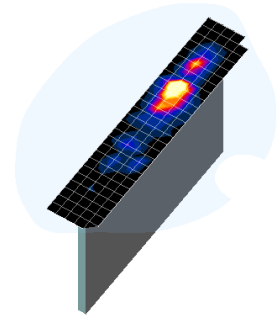
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2.2 SAR Measurement Procedure

The evaluation was performed using the following procedure compliant to FCC KDB Publication 865664 D01v01r04 and IEEE 1528-2013:

1. The SAR distribution at the exposed side of the head or body was measured at a distance no greater than 5.0 mm from the inner surface of the shell. The area covered the entire dimension of the device-head and body interface and the horizontal grid resolution was determined per FCC KDB Publication 865664 D01v01r04 (See Table 2-1) and IEEE 1528-2013.
2. The point SAR measurement was taken at the maximum SAR region determined from Step 1 to enable the monitoring of SAR fluctuations/drifts during the 1g/10g cube evaluation. SAR at this fixed point was measured and used as a reference value.
3. Based on the area scan data, the peak of the region with maximum SAR was determined by spline interpolation. Around this point, a volume was assessed according to the measurement resolution and volume size requirements of FCC KDB Publication 865664 D01v01r04 (See Table 2-1) and IEEE 1528-2013. On the basis of this data set, the spatial peak SAR value was evaluated with the following procedure (see references or the DASY manual online for more details):
 - a. SAR values at the inner surface of the phantom are extrapolated from the measured values along the line away from the surface with spacing no greater than that in Table . The extrapolation was based on a least-squares algorithm. A polynomial of the fourth order was calculated through the points in the z-axis (normal to the phantom shell).
 - b. After the maximum interpolated values were calculated between the points in the cube, the SAR was averaged over the spatial volume (1g or 10g) using a 3D-Spline interpolation algorithm. The 3D-spline is composed of three one-dimensional splines with the "Not a knot" condition (in x, y, and z directions). The volume was then integrated with the trapezoidal algorithm. One thousand points (10 x 10 x 10) were obtained through interpolation, in order to calculate the averaged SAR.
 - c. All neighboring volumes were evaluated until no neighboring volume with a higher average value was found.
4. The SAR reference value, at the same location as step 2, was re-measured after the zoom scan was complete to calculate the SAR drift. If the drift deviated by more than 5%, the SAR test and drift measurements were repeated.



Sample SAR Area Scan

**Table 2-1
Area and Zoom Scan Resolutions per FCC KDB Publication 865664 D01v01r04***

Frequency	Maximum Area Scan Resolution (mm) ($\Delta x_{\text{area}}, \Delta y_{\text{area}}$)	Maximum Zoom Scan Resolution (mm) ($\Delta x_{\text{zoom}}, \Delta y_{\text{zoom}}$)	Maximum Zoom Scan Spatial Resolution (mm)			Minimum Zoom Scan Volume (mm) (x,y,z)
			Uniform Grid	Graded Grid		
				$\Delta z_{\text{zoom}}(n)$	$\Delta z_{\text{zoom}}(n=1)^*$	
≤ 2 GHz	≤ 15	≤ 8	≤ 5	≤ 4	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 30
2-3 GHz	≤ 12	≤ 5	≤ 5	≤ 4	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 30
3-4 GHz	≤ 12	≤ 5	≤ 4	≤ 3	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 28
4-5 GHz	≤ 10	≤ 4	≤ 3	≤ 2.5	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 25
5-6 GHz	≤ 10	≤ 4	≤ 2	≤ 2	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 22

*Also compliant to IEEE 1528-2013 Table 6

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3 SAR CHARACTERIZATION

3.1 ECI and SAR Determination

For WWAN operations, this device uses different Exposure Condition Index (ECI) via MediaTek TAS to configure different time averaged power levels based on certain exposure scenarios. Depending on the detection scheme implemented in the watch, the worst-case SAR was determined by measurements for the relevant exposure conditions for that ECI. Detailed descriptions of the detection mechanisms are included in the operational description.

The exposure condition index (DSI) conditions used in Table 3-1 represent different exposure scenarios.

Table 3-1
DSI and Corresponding Exposure Scenarios

Scenario	Description	SAR Test Cases
(ECI = 1)	▪ Head (next-to-mouth use)	Wristwatch SAR per KDB Publication 447498 D04
(ECI = 0)	▪ Extremity (wrist exposure)	Wristwatch SAR per KDB Publication 447498 D04

3.2 SAR CHAR

SAR test results corresponding to P_{UE_max} for each antenna/technology/band/ECI can be found in FCC SAR Part 1 Report.

P_{limit} is calculated by linearly scaling with the measured SAR at the Part0/Part 1 to correspond to the SAR_design_target. When $P_{limit} < P_{max}$, Part 1 SAR was used as P_{limit} in the TAS. When $P_{limit} > P_{max}$ and Part0/Part 1= P_{max} , calculated P_{limit} was used in the TAS. All reported SAR obtained from the Part0/Part 1 SAR tests was less than SAR_Design_target + corresponding device uncertainty. The SAR measured in Part 0 at a fixed power level was also used for Part 1 report. The final P_{limit} determination for each exposure scenario corresponding to SAR_design_target are shown in the table below.

Table 3-2
 P_{limit} Determination for MTK TAS

Exposure Condition Index (ECI)	P_{limit} Determination Scenarios
1	The worst-case SAR exposure is determined as maximum SAR normalized to the limit based on 1g Head (next-to-mouth use) Wristwatch SAR at 10 mm.
0	The worst-case SAR exposure is determined as maximum SAR normalized to the limit based on 10g Extremity (wrist exposure) Wristwatch SAR at 0 mm.

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**Table 3-3
SAR Characterizations**

Exposure Scenario:	Maximum Tune-up Output Power*	Head	Extremity
Averaging Volume:		1g	10g
Spacing:		10 mm	0 mm
ECl:		1	0
Technology/Band	Pmax		
LTE Band 71	24.50	54.00	31.00
LTE Band 12	24.50	48.80	29.80
LTE Band 17	24.50	N/A	N/A
LTE Band 13	24.50	48.90	29.30
LTE Band 14	24.50	48.90	28.70
LTE Band 26	24.50	54.20	30.00
LTE Band 5	24.50	51.20	32.90
LTE Band 4	24.00	N/A	N/A
LTE Band 66	24.00	28.90	37.80
LTE Band 2	24.00	N/A	N/A
LTE Band 25	24.00	26.50	37.80
LTE Band 7	24.00	19.20	36.30
LTE Band 41	24.00	19.30	35.40
LTE Band 53	20.00	35.30	29.00
NR Band n71	24.50	51.00	31.20
NR Band n12	24.50	54.00	28.30
NR Band n14	24.50	51.00	29.00
NR Band n26	24.50	49.30	30.00
NR Band n5	24.50	49.20	29.80
NR Band n66	24.00	29.20	36.90
NR Band n2	24.00	N/A	N/A
NR Band n25	24.00	25.80	37.10
NR Band n7	24.00	20.00	35.70
NR Band n41	24.00	19.90	35.50
NR Band n53	20.00	35.40	26.30

Notes:

1. All P_{limit} and maximum tune up output power P_{max} levels entered in the above table correspond to average power levels after accounting for duty cycle in the case of LTE TDD modulation schemes.
2. When $P_{max} < P_{limit}$, the DUT will operate at a power level up to P_{max} .
3. The SAR design limit is determined by accounting for device uncertainty, and the P_{sub6} limit is defined as the time-averaged power corresponding to the SAR design limit.
4. Maximum tune up output power P_{max} is used to configure EUT during RF tune up procedure. The maximum allowed output power is equal to maximum Tune up output power + 1.20 dB device design uncertainty.

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EQUIPMENT LIST

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
Agilent	E4404B	Spectrum Analyzer	N/A	N/A	N/A	MY45113242
Agilent	E4438C	ESG Vector Signal Generator	11/2/2025	Annual	11/2/2026	MY45093852
Agilent	E4438C	ESG Vector Signal Generator	3/23/2026	Annual	3/23/2027	MY45092078
Agilent	N5182A	MXG Vector Signal Generator	4/13/2026	Annual	4/13/2027	MY48180366
Agilent	8753ES	S-Parameter Vector Network Analyzer	10/28/2025	Annual	10/28/2026	MY40003841
Agilent	8753ES	S-Parameter Vector Network Analyzer	10/27/2025	Annual	10/27/2026	US39170118
Agilent	E5515C	Wireless Communications Test Set	CBT	N/A	CBT	GB46310798
Agilent	E5515C	Wireless Communications Test Set	CBT	N/A	CBT	GB41450275
Agilent	N4010A	Wireless Connectivity Test Set	N/A	N/A	N/A	GB46170464
Amplifier Research	1551G6	Amplifier	CBT	N/A	CBT	433973
Amplifier Research	1551G6	Amplifier	CBT	N/A	CBT	433974
Amplifier Research	150A100C	Amplifier	CBT	N/A	CBT	350132
Anritsu	MN8110B	I/O Adaptor	CBT	N/A	CBT	6261747881
Anritsu	ML2496A	Power Meter	8/21/2025	Annual	8/21/2026	1138001
Anritsu	MA2411B	Pulse Power Sensor	10/14/2025	Annual	10/14/2026	1726262
Anritsu	MA2411B	Pulse Power Sensor	10/14/2025	Annual	10/14/2026	1027293
Insize	1108-150	Insize - Digital Caliper	1/7/2026	Annual	1/7/2027	1410255640
Anritsu	MA24106A	USB Power Sensor	2/20/2026	Annual	2/20/2027	1520501
Anritsu	MA24106A	USB Power Sensor	12/12/2025	Annual	12/12/2026	1344554
Control Company	4352	Long Stem Thermometer	12/22/2025	Biennial	12/22/2027	250770121
Control Company	4352	Long Stem Thermometer	12/22/2025	Biennial	12/22/2027	250770096
Control Company	4040	Therm./ Clock/ Humidity Monitor	12/29/2025	Biennial	12/29/2027	250778120
Control Company	4040	Therm./ Clock/ Humidity Monitor	10/24/2025	Biennial	10/24/2027	250652331
Control Company	4040	Therm./ Clock/ Humidity Monitor	10/15/2024	Biennial	10/15/2026	240763503
Keysight Technologies	N9020A	MXA Signal Analyzer	6/5/2026	Annual	6/5/2027	MY54500644
Agilent	N9020A	MXA Signal Analyzer	7/7/2025	Biennial	7/7/2027	MY56470202
MCL	BW-N6W5+	6dB Attenuator	CBT	N/A	CBT	1139
Mini-Circuits	VLF-6000+	Low Pass Filter DC to 6000 MHz	CBT	N/A	CBT	N/A
Mini-Circuits	VLF-6000+	Low Pass Filter DC to 6000 MHz	7/22/2025	Annual	7/22/2026	32028
Mini-Circuits	BW-N20W5+	DC to 18 GHz Precision Fixed 20 dB Attenuator	CBT	N/A	CBT	N/A
Mini-Circuits	NLP-1200+	Low Pass Filter DC to 1000 MHz	CBT	N/A	CBT	N/A
Mini-Circuits	NLP-2950+	Low Pass Filter DC to 2700 MHz	CBT	N/A	CBT	N/A
Mini-Circuits	BW-N20W5	Power Attenuator	CBT	N/A	CBT	1226
Mini-Circuits	ZUDC10-83-S+	Directional Coupler	CBT	N/A	CBT	2050
Narda	4772-3	Attenuator (3dB)	CBT	N/A	CBT	9406
Narda	BW-53W2	Attenuator (3dB)	CBT	N/A	CBT	120
Pasternack	NC-100	Torque Wrench	5/29/2025	Biennial	5/29/2027	N/A
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	CBT	N/A	CBT	120504
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	CBT	N/A	CBT	109366
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	CBT	N/A	CBT	155128
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	CBT	N/A	CBT	102060
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	CBT	N/A	CBT	168544
SPEAG	DAK-3.5	Dielectric Assessment Kit	11/10/2025	Annual	11/10/2026	1277
SPEAG	DAKS-3.5	Portable Dielectric Assessment Kit	8/5/2025	Annual	8/5/2026	1041
SPEAG	MAIA	Modulation and Audio Interference Analyzer	N/A	N/A	N/A	1237
SPEAG	MAIA	Modulation and Audio Interference Analyzer	N/A	N/A	N/A	1331
SPEAG	MAIA	Modulation and Audio Interference Analyzer	N/A	N/A	N/A	1390
SPEAG	DAK-12	Dielectric Assessment Kit (4MHz - 3GHz)	3/3/2026	Annual	3/3/2027	1102
GW Instek	GPS-3030DD	DC Power Supply	N/A	N/A	N/A	E1883874
SPEAG	CLA-13	Confined Loop Antenna	11/17/2025	Annual	11/17/2026	1004
SPEAG	D750V3	750 MHz SAR Dipole	5/10/2024	Triennial	5/10/2027	1034
SPEAG	D750V3	750 MHz SAR Dipole	9/13/2023	Triennial	9/13/2026	1097
SPEAG	D835V2	835 MHz SAR Dipole	10/25/2024	Biennial	10/25/2026	4d040
SPEAG	D1640V2	1640 MHz SAR Dipole	11/3/2025	Annual	11/3/2026	321
SPEAG	D1750V2	1750 MHz SAR Dipole	11/6/2025	Annual	11/6/2026	1040
SPEAG	D1900V2	1900 MHz SAR Dipole	10/15/2025	Annual	10/15/2026	Sd030
SPEAG	D1900V2	1900 MHz SAR Dipole	9/7/2023	Triennial	9/7/2026	Sd181
SPEAG	D2450V2	2450 MHz SAR Dipole	10/23/2024	Biennial	10/23/2026	921
SPEAG	D2450V2	2450 MHz SAR Dipole	11/10/2025	Annual	11/10/2026	855
SPEAG	D2600V2	2600 MHz SAR Dipole	9/12/2023	Triennial	9/12/2026	1069
SPEAG	D2600V2	2600 MHz SAR Dipole	11/10/2025	Annual	11/10/2026	1068
SPEAG	D5GHzV2	5 GHz SAR Dipole	8/6/2025	Annual	8/6/2026	1123
SPEAG	D5GHzV2	5 GHz SAR Dipole	11/8/2024	Biennial	11/8/2026	1066
SPEAG	DAE4	Dasy Data Acquisition Electronics	12/3/2025	Annual	12/3/2026	1644
SPEAG	DAE4	Dasy Data Acquisition Electronics	2/6/2026	Annual	2/6/2027	1402
SPEAG	DAE4	Dasy Data Acquisition Electronics	8/6/2025	Annual	8/6/2026	793
SPEAG	DAE4	Dasy Data Acquisition Electronics	10/14/2025	Annual	10/14/2026	1237
SPEAG	DAE4	Dasy Data Acquisition Electronics	9/10/2025	Annual	9/10/2026	1646
SPEAG	DAE4	Dasy Data Acquisition Electronics	3/9/2026	Annual	3/9/2027	604
SPEAG	DAE4	Dasy Data Acquisition Electronics	3/10/2026	Annual	3/10/2027	1323
SPEAG	DAE4	Dasy Data Acquisition Electronics	1/12/2026	Annual	1/12/2027	1465
SPEAG	EX3DV4	SAR Probe	9/15/2025	Annual	9/15/2026	7782
SPEAG	EX3DV4	SAR Probe	3/10/2026	Annual	3/10/2027	7421
SPEAG	EX3DV4	SAR Probe	2/12/2026	Annual	2/12/2027	7499
SPEAG	EX3DV4	SAR Probe	3/10/2026	Annual	3/10/2027	7551
SPEAG	EX3DV4	SAR Probe	2/12/2026	Annual	2/12/2027	7427
SPEAG	EX3DV4	SAR Probe	10/10/2025	Annual	10/10/2026	3746
SPEAG	EX3DV4	SAR Probe	8/13/2025	Annual	8/13/2026	3837
SPEAG	EX3DV4	SAR Probe	12/23/2025	Annual	12/23/2026	7490

For SAR measurements

Note:

1. CBT (Calibrated Before Testing). Prior to testing, the measurement paths containing a cable, amplifier, attenuator, coupler or filter were connected to a calibrated source (i.e. a signal generator) to determine the losses of the measurement path. The power meter offset was then adjusted to compensate for the measurement system losses. This level offset is stored within the power meter before measurements are made. This calibration verification procedure applies to the system verification and output power measurements. The calibrated reading is then taken directly from the power meter after compensation of the losses for all final power measurements.
2. Each equipment item was used solely within its respective calibration period.

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6

MEASUREMENT UNCERTAINTIES

Applicable for SAR measurements < 6 GHz:

SAR Uncertainty Budget based on IEEE 1528-2013 and SPEAG (0.3 GHz to 6 GHz)

a	b	c	d	e $f(d,k)$	f	g	h $cx/f/e$	i cxg/e	k
Uncertainty component	Reference	Tol. ($\pm$ %)	Prob. dist.	Dvi.	ci (1g)	ci (10g)	1g ui ($\pm$ %)	10g ui ($\pm$ %)	vi
Measurement system									
Probe calibration	E.2.1	6.55	N	1	1	1	6.55	6.55	∞
Axial isotropy	E.2.2	0.25	N	1	0.707	0.707	0.18	0.18	∞
Hemispherical isotropy	E.2.2	1.30	N	1	0.707	0.707	0.92	0.92	∞
Boundary effect	E.2.3	2.00	R	1.73	1	1	1.15	1.15	∞
Linearity	E.2.4	0.30	R	1.73	1	1	0.17	0.17	∞
System detection limits	E.2.4	0.25	R	1.73	1	1	0.14	0.14	∞
Modulation response	E.2.5	4.80	R	1.73	1	1	2.77	2.77	∞
Readout electronics	E.2.6	0.30	N	1	1	1	0.30	0.30	∞
Response time	E.2.7	1.01	R	1.73	1	1	0.58	0.58	∞
Integration time	E.2.8	2.60	R	1.73	1	1	1.50	1.50	∞
RF ambient conditions - noise	E.6.1	3.00	R	1.73	1	1	1.73	1.73	∞
RF ambient conditions - reflections	E.6.1	3.00	R	1.73	1	1	1.73	1.73	∞
Probe positioner mechanical tolerance	E.6.2	0.04	R	1.73	1	1	0.02	0.02	∞
Probe positioning with respect to phantom shell	E.6.3	0.80	R	1.73	1	1	0.46	0.46	∞
Extrapolation, interpolation, and integration algorithms for max. SAR evaluation	E.5	4.00	R	1.73	1	1	2.31	2.31	∞
Test sample related									
Test sample positioning	E.4.2	3.12	N	1	1	1	3.12	3.12	35
Device holder uncertainty	E.4.1	1.67	N	1	1	1	1.67	1.67	5
Output power variation - SAR drift	E.2.9	5.00	R	1.73	1	1	2.89	2.89	∞
SAR scaling	E.6.5	0.00	R	1.73	1	1	0.00	0.00	∞
Phantom and tissue parameters									
Phantom shell uncertainty - shape, thickness and permittivity	E.3.1	7.60	R	1.73	1	1	4.39	4.39	∞
Uncertainty in SAR correction for deviations in permittivity and conductivity	E.3.2	0.00	N	1	1	1	0.00	0.00	∞
Liquid conductivity measurement	E.3.3	2.50	N	1	0.78	0.71	1.95	1.78	∞
Liquid permittivity measurement	E.3.3	2.50	N	1	0.23	0.26	0.58	0.65	∞
Liquid conductivity - temperature uncertainty	E.3.4	3.36	R	1.73	0.78	0.71	1.51	1.38	∞
Liquid permittivity - temperature uncertainty	E.3.4	0.77	R	1.73	0.23	0.26	0.10	0.12	∞
Liquid Conductivity - deviation from target values	E.3.2	5.00	R	1.73	0.64	0.43	1.85	1.24	∞
Liquid Permittivity - deviation from target values	E.3.2	5.00	R	1.73	0.60	0.49	1.73	1.41	∞
Combined standard uncertainty							11.0	10.8	40
Expanded uncertainty (95% confidence interval)							21.9	21.6	

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SAR Uncertainty Budget based on IEC/IEEE 62209-1528:2020 (4 MHz to 10 GHz)

Symbol	Input quantity X (source of uncertainty)	Ref.	Prob. Dist. PDFi	Unc. a(xi)	Div. qi	$u(x_i) = a(x_i)/q_i$	ci (1g)	ci (10g)	$u(y) = cixu(x_i) 1g (\pm \%)$	$u(y) = cixu(x_i) 10g (\pm \%)$	vi
Measurement system errors											
CF	Probe calibration	8.4.1.1	N (k=2)	9.30	1	9.30	1	1	9.30	9.30	∞
CFdrift	Probe calibration drift	8.4.1.2	R	1.70	1.73	0.98	1	1	0.98	0.98	∞
LIN	Probe linearity and detection limit	8.4.1.3	R	4.70	1.73	2.71	1	1	2.71	2.71	∞
BBS	Broadband signal	8.4.1.4	R	2.80	1.73	1.62	1	1	1.62	1.62	∞
ISO	Probe isotropy	8.4.1.5	R	7.60	1.73	4.39	1	1	4.39	4.39	∞
DAE	Other probe and data acquisition errors	8.4.1.6	N	2.40	1	2.40	1	1	2.40	2.40	∞
AMB	RF ambient and noise	8.4.1.7	N	1.80	1	1.80	1	1	1.80	1.80	∞
Δxyz	Probe positioning errors	8.4.1.8	N	0.30	1	0.30	1	1	0.30	0.30	∞
DAT	Data processing errors	8.4.1.9	N	3.50	1.00	3.50	1	1	3.50	3.50	∞
Phantom and device (DUT or validation antenna) errors											
LIQ(σ)	Measurement of phantom conductivity	8.4.2.1	N	2.50	1	2.50	0.78	0.71	1.95	1.78	∞
LIQ(Te)	Temperature effects (medium)	8.4.2.2	R	5.40	1.73	3.12	0.78	0.71	2.43	2.21	∞
EPS	Shell permittivity	8.4.2.3	R	14.00	1.73	8.08	0.5	0.5	4.04	4.04	∞
DIS	Distance between the radiating element of the DUT and the phantom medium	8.4.2.4	N	2.00	1	2.00	2	2	4.00	4.00	∞
Dxyz	Repeatability of positioning the DUT or source against the phantom	8.4.2.5	N	3.12	1	3.12	1	1	3.12	3.12	35
H	Device holder effects	8.4.2.6	N	1.67	1	1.67	1	1	1.67	1.67	5
MOD	Effect of operating mode on probe sensitivity	8.4.2.7	R	2.40	1.73	1.39	1	1	1.39	1.39	∞
TAS	Time-average SAR	8.4.2.8	R	1.73	1.73	1.00	1	1	1.00	1.00	∞
RFdrift	Variation in SAR due to drift in output power of DUT	8.4.2.9	N	2.50	1	2.50	1	1	2.50	2.50	∞
VAL	Validation antenna uncertainty (validation measurement only)	8.4.2.10	N	0.00	1	0.00	1	1	0.00	0.00	∞
Pin	Uncertainty in accepted power (validation measurement only)	8.4.2.11	N	0.00	1	0.00	1	1	0.00	0.00	∞
Corrections to the SAR result (if applied)											
C(e', σ)	Phantom deviation from target	8.4.3.1	R	5.00	1.73	2.89	0.64	0.43	1.85	1.24	∞
C(R)	SAR scaling	8.4.3.2	R	0.00	1.73	0.00	1	1	0.00	0.00	∞
u(ASAR)	Combined uncertainty								14.32	14.20	40
U	Expanded uncertainty and effective degrees of freedom								28.65	28.40	

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